Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination LI ET AL. | Examiner | Art Unit | Sin J. Lee | 1752 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,074,801	06-2000	Iwasa et al.	430/270.1
	В	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-	`		
	Н	US-			
	-	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				,	
	0					
	Р					
	Q					
	R					
	s					
	Т					-

NON-PATENT DOCUMENTS

*					
<u> </u>		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	٧				
	w				
	х				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.